

EMC - TEST REPORT EUROPEAN STANDARD EN 60601-1-2: 2007 and IEC 60601-1-2: 2007

i est Report File No.	:	SC1010487A-01-02	Date of Issue: 13 January 2011
Model / Serial No.	:	MODEL: X10 / S/N:	101000003
Product Type	:	B-ALERT SYSTEM	
Configuration Test Mode	:	PATIENT MODE	
Applicant	:	ADVANCED BRAIN	MONITORING SYSTEMS
Manufacturer	:	ADVANCED BRAIN	MONITORING SYSTEMS
License holder	:	ADVANCED BRAIN	MONITORING SYSTEMS
Address	:	2850 Pio Pico Drive	, Suite A
	:	Carlsbad, CA 92008	S – USA
Test Result	:	■ Positive	□ Negative
Test Project Number	:	SC1010487A	<u> </u>
Total pages - Test Report	:	48	

This TÜV SÜD America, Inc. report results apply only to the specific sample tested under the stated test conditions agreed upon by the client, prior to testing. Production compliance is the responsibility of the client. TÜV SÜD America, Inc. shall have no liability for deductions, inferences or generalizations drawn from this report by the client or others. This report shall only be reproduced in its entirety.

The client shall not use this report to claim product endorsement by NVLAP, NIST, or any agency of the U.S. Government. (TÜV SÜD America, Inc.'s (San Diego, California) NVLAP Lab Code: 100268-0.)



DIRECTORY Test Report

	Pages
Test Report:	1 – 48
Directory	2
Test Regulations	3
General Remarks and Summary	17
Equipment:	
Conducted Emissions	5
Radiated Emissions	6
Current Harmonics Tests	7
Voltage Fluctuation and Flicker Test	8
Electrostatic Discharge	9
Radiated Electromagnetic Fields	10
Fast Transients (Burst)	11
Surge Transients	12
Conducted Disturbance	13
Power Frequency Magnetic Field	14
Voltage Dips, Interruptions and Variations	15
Technical Documentation	
Test Data Sheets and Test Setup Drawing(s)	18
Appendices	
Appendix A - Test Setups (Photographs)	31
Appendix B - Product Information Form(s)	40
Appendix C - Change History	47
Appendix D - Supplemental Information	48



TEST REGULATIONS:

The tests were performed according to the following regulations:

		_	
■ - IEC 60601-1-2: 2007		2: 2007	
■ - CISPR 11: 2009 ■ - EN 55011: 2007; Amendment	A2: 2007	□ - Class A □ - Class A	■ - Class B ■ - Class B
□ - EN 61000-3-2: 2006 □ - IEC 61000-3-2: 2005; Amendn	nent 1, 2008		
□ - EN 61000-3-3: 1995, Amendm □ - IEC 61000-3-3: 2008	ent 2: 2006		
■ - IEC 61000-4-2: 2008 ■ - IEC 61000-4-3: 2008 □ - IEC 61000-4-4: 2007 □ - IEC 61000-4-5: 2005 □ - IEC 61000-4-6: 2008 ■ - IEC 61000-4-11: 2004	EN 6100 EN 6100 EN 6100 EN 6100 EN 6100	0-4-2: 1995; Amendment 2, 200 0-4-3: 2006, Amendment 1, 200 0-4-4: 2004 0-4-5: 2006 0-4-6: 2007 0-4-8: 1993; Amendment 1, 200 0-4-11: 2004	08

Note: Un-dark squares are not applicable



Environmental Conditions In The Laboratory:

<u>Actual</u>

Temperature : 18 - 25 °C Relative Humidity : 42 - 55 %

Atmospheric Pressure : 98.9 – 100.8 kPa

Power Supply Utilized:

Power supply system : 3.7 VDC

Symbol Definitions:

■ - Applicable

□ - Not Applicable



Test Conditions: CONDUCTED EMISSIONS (Interference Voltage)

The CONDUCTED EMISSIONS (Interference Voltage) measurements were performed in the following location at the San Diego Testing Facility:

■ - Test not applicable	
OPERATING MODE DESCRIPTION	N:
Remarks: DC Powered. Testing N	lot Applicable.



Test Conditions: RADIATED EMISSIONS (Electric Field)

The RADIATED EMISSIONS (Electric Field) measurements were performed in the following location at the San Diego Testing Facility:

	Test not applicable	
II I -	Lest not anniicanie	
_	i cot not applicable	

■ - SR6 (3 and 10 meter Semi-Anechoic Chamber), San Diego, CA (Date of listing June 21, 2010. Site Verification NSA)

Remarks: One year calibration cycle for all test equipment.

Testing was performed at a test distance of:

■ - 10 meters

Test Equipment Used:

Model No.:	Prop. No.:	Description:	Manufacturer:	Serial No./Version No.:
3142C	SA1033	Antenna, Bilog	EMCO	44556
ESMI	SA1043,44	EMI Test Receiver	Rhode & Schwarz	848926/003
PAM-0202	SA1016	Pre-Amplifier	PAM	187
ES-K1		Test Software	Rohde & Schwarz	1.60 Service Pack 2
Result:				
- Pass		□ - Fail		
		ı		
OPERATING	MODE DESC	RIPTION: Patient Mode		



Test Conditions: CURRENT HARMONICS TEST

The CURRENT HARMONICS TEST measurements were performed in the following location at the San Diego Testing Facility:

Testing Facility:	
■ - Test not applicable	
OPERATING MODE DESCRIPTION:	
Remarks: DC Powered. Testing Not	t Applicable.



Test Conditions: VOLTAGE FLUCTUATION AND FLICKER TEST

The VOLTAGE FLUCTUATION AND FLICKER TEST measurements were performed in the following location at the San Diego Testing Facility:

■ - Test no	ot applicable]
OPERATIN	G MODE DESCRIPTION:	
Remarks:	DC Powered. Testing Not	t Applicable.



Test Conditions: ELECTROSTATIC DISCHARGE (ESD)

The immunity against *ELECTROSTATIC DISCHARGE (ESD)* was performed in the following location at the San Diego Testing Facility:

☐ - Test not applicable

■ - TR-1, Test Room, 20.5' x 17' x 9'

Test Equipment Used:

Model No.:	Prop. No.:	Description:	Manufacturer:	Serial No./Version No.:		
NSG435	6541	ESD Simulator System	Schaffner	751		
HCP VCP		Horizontal Coupling Plane Vertical Coupling Plane	TÜV SÜD America TÜV SÜD America	 		
VCP		vertical Coupling Flane	TOV SOD America			
NSG435		Test Software	Schaffner			
Test Specificati	on:					
Discharge Voltag	ge (Air):	■ - ± 2 kV	□ - ± 6 kV	□ - ± 15 kV		
0	,	■ - ± 4 kV	■ - ± 8 kV	□ - ± kV		
Discharge Voltag	ge (Contact):	■ - ± 2 kV	■ - ± 4 kV	□ - ± 8 kV		
		□ - ± 3 kV	■ - ± 6 kV	□ - ± kV		
Discharge Imped	dance:	■ - 330 Ω / 150 pF				
Discharge Repet	tition Rate:	■ - ≥ 1 sec.				
Number of Disch	narges:	■ - 10 Positive	■ - 10 Negative			
Kind of Discharg	es:	Direct Discharge	Indirect Discharge			
		■ - Air	■ - HCP			
		- Contact	■ - VCP			
Polarity:		■ - Positive	■ - Negative			
Location of Disch	harge:	■ - See Data Record(s)	☐ - Each location on the	e surface touchable by hand		
Result:						
■ - Pass		□ - Fail				
■ - No degradat		- Met Criterion A				
☐ - Distortion of		- Met Criterion B				
☐ - Error of func		- Met Criterion C				
☐ - Loss of funct	uon	- Unrecoverable Failure				
OPERATING MO	OPERATING MODE DESCRIPTION: Patient Mode					
Remarks:						



Test Conditions: RADIATED ELECTROMAGNETIC FIELDS

The immunity against RADIATED ELECTROMAGNETIC FIELDS was performed in the following location at the San Diego Testing Facility:

☐ - Test not applicable	
-------------------------	--

■ - SR-1, Shielded Room, 12' x 24' x 10', Metal, Compact Anechoic Chamber

Test Equipment Used:

Model No.: STLP9149 AT5080M1 FM 2000 FP 2000	Prop No.: 7535 7508 6507 6689	Description: Antenna, Log Periodic Antenna, Log Periodic Isotropic Field Monitor Isotropic Field Probe	Manufacturer: Schwarzbeck Amplifier Research Amplifier Research Amplifier Research	Serial No./Version No.: 9149-022 0323556 14677 14803
7005 436A 8481A N5181A	7510 6584 6534 7504	RF Power Amplifier Power Meter Power Sensor Signal Generator	Ophir, 0.8 – 6GHz Hewlett Packard Hewlett Packard Agilent	1001 1911A04722 1926A27807 MY46240083
C3		Test Software	TÜV SÜD America	4.01.0 BUILD 0
Test Specification:				
Frequency Range:		□ - 80 - 1000 MHz	■ - 80 - 2500 MHz	□ - 80 - 2700 MHz
Field Strength:		□ - 1 V/m	■ - 3 V/m □ - 10 V	/m 🗆 V/m
Distance Antenna -	EUT:	□ - 1 m	■ - 3 m	
Modulation:		■ - AM: □ - Un-Modulated	□ - FM: ■	- 80 % ■ - 10 Hz
		■ - Sine Wave:	□ - Pulse ON	N/OFF Duty Cycle: %
Step:		☐ - 1 second dwell	■ - 3 seconds dwell	- 1%
Polarization of Anter	nna:	■ - Horizontal	■ - Vertical	
Result: ■ - Pass		□ - Fail		
■ - No degradation □ - Distortion of fun □ - Error of function □ - Loss of function	ction	Met Criterion AMet Criterion BMet Criterion CUnrecoverable Failure	9	
OPERATING MODE	E DESCRIPT	Patient Mode		



Test Conditions: FAST TRANSIENTS (BURST)

The immunity against FAST TRANSIENTS (BURST) was performed in the following location at the San Diego Testing Facility:

resting rubinty.		
■ - Test not applicable		
OPERATING MODE DESCRIPTION	ON:	
Remarks: DC Powered. Testing	y Not Applicable.	



Test Conditions: SURGE TRANSIENTS

The immunity against *SURGE TRANSIENTS* was performed in the following location at the San Diego Testing Facility:

Testing Facility:	
■ - Test not applicable	
OPERATING MODE DESCRIPTION:	
Remarks: DC Powered. Testing Not	t Applicable.



Test Conditions: CONDUCTED DISTURBANCE

The immunity against *CONDUCTED DISTURBANCE* was performed in the following location at the San Diego Testing Facility:

Testing Fa	cility:	
■ - Test no	ot applicable	
OPERATIN	G MODE DESCRIPTION:	
Remarks:	DC Powered. Testing Not	t Applicable.



□ - Test not applicable

■ - TR-2, Test Room, 16' x 10' x 9'

Test Conditions: POWER FREQUENCY MAGNETIC FIELD

The immunity against *POWER FREQUENCY MAGNETIC FIELD* was performed in the following location at the San Diego Testing Facility:

Test Equipment Us	sed:			
Model No.: Prop. No.: Desc		Description:	Manufacturer:	Serial No./Version No.
1C-1m 1000-8	1C-1m 6543 Loop		TÜV SÜD America TÜV SÜD America	N/A N/A
■ - Test requires no	software.			
Test Specification:	:			
Frequency Range:		■ - 50 Hz	■ - 60 Hz	□ - 400 Hz
Field level (EMF):		□ - 1 A/m □ - 30 A/m	■ - 3 A/m □ - 100 A/m	□ - 10 A/m □ A/m
Short Field (1-3 sec):	□ - 300 A/m	□ - 1000 A/m	□ A/m
Duration:		■ - 60 seconds	□ seconds	
Axis of Orientation:		■ - X-axis	■ - Y-axis	■ - Z-axis
Result: ■ - Pass		□ - Fail		
■ - No degradation □ - Distortion of fun □ - Error of function □ - Loss of function	ction 1	 Met Criterion A Met Criterion B Met Criterion C Unrecoverable Failun 	re	
OPERATING MOD	E DESCRIPT	TION: Patient Mode		
Romarks:				



Test Conditions: VOLTAGE DIPS, INTERRUPTIONS & VARIATIONS

The immunity against *VOLTAGE DIPS, INTERRUPTIONS & VARIATIONS* was performed in the following location at the San Diego Testing Facility:

■ - Test no	ot applicable	
OPERATIN	G MODE DESCRIPTION:	
Remarks:	DC Powered. Testing Not	Applicable.



Equipment Under Test (EUT) Test Operation Mode:

The equipment under test was operated under the following conditions during testing:

Patient Mode

□ -

T dilotti Modo								
Configuration of the equipment under test:								
☐ - See Constructional Data Form in Appendix B								
■ - See Product Information Form(s) in	■ - See Product Information Form(s) in Appendix B							
The following peripheral devices and	d interface c	cables were connected during the testing:						
-		Type:						
		Type:						
o -		Type:						
o-		Type:						
o -		Type:						
o		Type:						
□ - Unshielded power cable□ - Unshielded cables								
□ - Shielded cables	MPS. No.:							
□ - Customer specific cables □ -								



GENERAL REMARKS:

Patient Mode using Calibration Generator for each test function.

SUMMARY:

The tests marked with darkened squares were performed according to the regulations cited on page 3

Performed

The Equipment Under Test

■ - Fulfills all of the general approval requirements cited on page 3

Statement of Measurement Uncertainty

The data and results referenced in this document are true and accurate. The test system for conducted emissions is defined as the LISN, tuned receiver or spectrum analyzer, and coaxial cable. This test system has a measurement uncertainty of ±1.8 dB. The test system for radiated emissions is defined as the antenna, the pre-amplifier, the spectrum analyzer and the coaxial cable. This test system has a measurement uncertainty of ±4.8 dB. The measurement uncertainty values for conducted and radiated emissions meet the requirements as expressed in CISPR 16-4-2. The equipment comprising the test systems is calibrated on an annual basis. The reader is cautioned that there is some measurement variability due to the tolerances of the test equipment that can contribute to a nominal product measurement uncertainty. Furthermore, component differences and manufacturing process variability of production units similar to that tested may result in additional product uncertainty. If necessary, refer to the test lab for the actual measurement uncertainty for specific tests.

Equipment Received Date:	30 November 2010
Testing Start Date:	30 November 2010
Testing End Date:	12 January 2011

- TÜV SÜD AMERICA, INC. -

Reviewing Engineer: Test Engineer:

Dail U Jus

David Gray, Lan Sayasane, (Senior EMC Engineer) (EMC Technician)

Page 17 of 48



Technical Documentation

Test Data Sheets

and

Test Setup Drawing(s)



TUV SC1010487

EUT: B-Alert X10

Advance Brain Monitoring Systems Manufacturer:

Patient mode with calibration generator Operating Condition:

Test Site: SR6

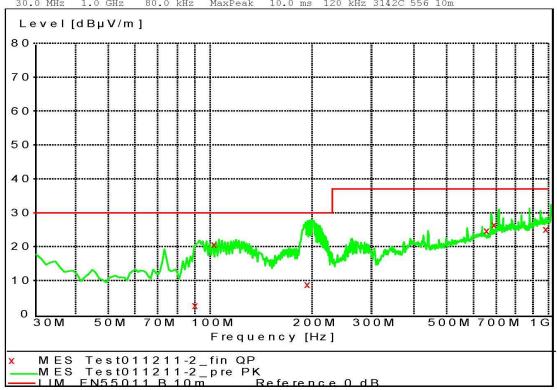
Kathy MacKenzie EN55011 class B Operator: Test Specification:

Comment:

Internal Battery powered Start of Test: 1/12/2011 / 11:24:01AM

SCAN TABLE: "EN55011 10M(BCL)"

Short Description: EN 55011 Field Strength
Start Stop Step Detector Meas. IF Transducer
Frequency Frequency Width Time Bandw.
30.0 MHz 1.0 GHz 80.0 kHz MaxPeak 10.0 ms 120 kHz 3142C 556 10m



MEASUREMENT RESULT: "Test011211-2 fin QP"

1/12/2011 12:47PM Frequency Level Transd Limit Margin Height Azimuth Polarisation MHz dBµV/m dB dBµV/m dB cm deg 91.200000 2.60 -21.5 30.0 27.4 356.0 191.00 HORIZONTAL 103.840000 20.60 -21.1 30.0 9.4 342.0 354.00 HORIZONTAL

1/12/2011 1:02PM Test011211-2



MEASUREMENT RESULT: "Test011211-2_fin QP"

(continued) Frequency MHz	Level dBµV/m		Limit dBµV/m	Margin dB	Height cm	Azimuth deg	Polarisation
196.080000	8.80	-18.2	30.0	21.2	346.0	294.00	HORIZONTAL
663.680000	24.70	-5.0	37.0	12.3	102.0	24.00	VERTICAL
699.680000	26.40	-3.5	37.0	10.6	181.0	32.00	VERTICAL
995.280000	25.10	-0.5	37.0	11.9	177.0	318.00	VERTICAL

1/12/2011 1:02PM Test011211-2

Rev.No 1.0





Test Report#:	SC1010487	Test Area:	TR-1			
EUT Model #:	X10	Date:	December 21, 2010			
EUT Serial#:	101000003	EUT Power:	Battery 3.7 VDC	Temperature:	21.3	°C
Test Method:	EN61000-4-2			Air Pressure:	100.0	kPa
Customer:	Advanced Brain Monitoring Systems	Relative Humidity:	58.7	. %		
EUT Description:	B-Alert System			Page: 1 of 4	E.	
Notes:	Patient mode with calibration generate	or			10	,
	ND = No Discharge					

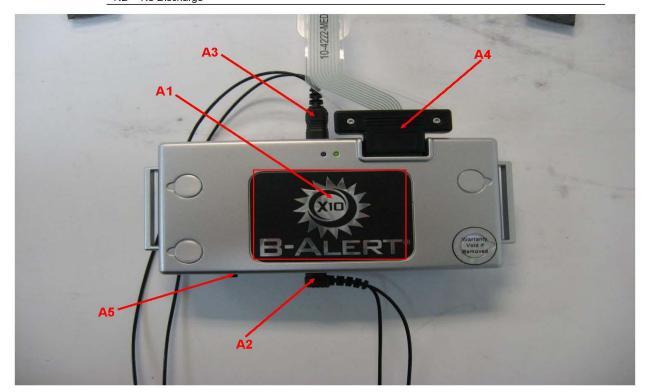
TEST	DISCHAR	GE TYPE	21	kV	4 1	κV	61	kV	8	kV		kV	Сом	PLIES		
POINT	DIRECT/	AIR/	RE	PS	RE	PS	RE	PS	RE	PS	RE	PS			CRITERIA	REMARKS
LOCATION	INDIRECT	CONTACT	+	(5)	+	-	+	200	+	=	1	353	YES	No	MET	
Front	Indirect	Contact	10	10	10	10	10	10					1		Α	HCP
Left	*	→	10	10	10	10	10	10					1		Α	•
Right	+	+	10	10	10	10	10	10					✓		Α	4
Rear	4	+	10	10	10	10	10	10					1		Α	4
Front	f	→	10	10	10	10	10	10					1		Α	VCP
Left	4	→	10	10	10	10	10	10					1		Α	Ψ
Right	4	+	10	10	10	10	10	10					✓		Α	4
Rear	4	→	10	10	10	10	10	10					1		Α	4
A1	Direct	Air		ND		ND			ND	ND			1		Α	
A2	4	*		ND					ND	ND			1		Α	
А3	4	→		ND						ND			1		Α	
Α4	¥	+		ND					ND	ND			1		Α	
A5	4	→	ND	ND	ND	ND			10	10			1		В	
A6	¥	Ψ		ND					ND	ND			1		Α	
Α7	4	+		ND						ND		0	✓	,	Α	
A8	4	Ψ.		ND						ND		6	✓		Α	
A9	4	+		ND		50.00			_	0.00			✓		Α	
A10	f	+	ND	ND	ND	ND			ND	ND			✓		Α	
				19								6				

Tested by:	Lan Sayasane	Days same		
10 Hamilton 11 - 40 - 40 - 10 - 10 - 10 - 10 - 10 -	Printed	Signature		
		Staple Party		
Reviewed by:	Stephen Rackleff			
	Printed	Signature		





Test Report#:	SC1010487	Test Area:	TR-1			
EUT Model #:	X10	Date:	December 21, 2010	•		
EUT Serial#:	101000003	EUT Power:	Battery 3.7 VDC	Temperature:	21.3	°C
Test Method:	EN61000-4-2			Air Pressure:	100.0	. kPa
Customer:	Advanced Brain Monitoring Systems			Relative Humidity:	58.7	%
EUT Description:	B-Alert System			Page: 2 of 4		
Notes:	Patient mode with calibration generate	or				,
	ND = No Discharge					

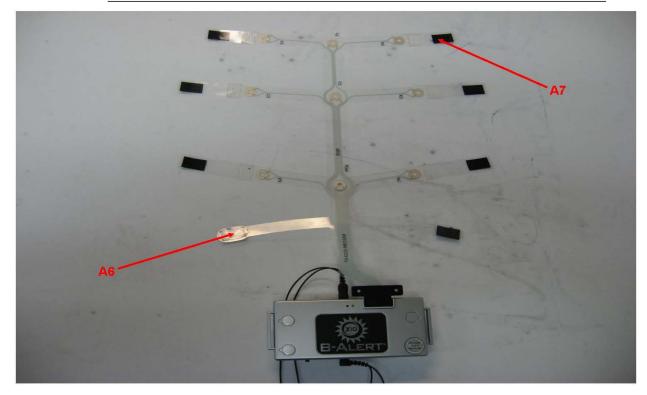


Tested by:	Lan Sayasane	San Assante
	Printed	Signature
Reviewed by:	Stephen Rackleff	Staple Parket Spiller
	Printed	Signature





Test Report #:	SC1010487	Test Area:	TR-1			
EUT Model #:	X10	Date:	December 21, 2010			
EUT Serial#:	101000003	EUT Power:	Battery 3.7 VDC	Temperature:	21.3	°C
Test Method:	EN61000-4-2			Air Pressure:	100.0	kPa
Customer:	Advanced Brain Monitoring Systems			Relative Humidity:	58.7	%
EUT Description:	B-Alert System			Page: 3 of 4		
Notes:	Patient mode with calibration generate	or			50	,
	ND = No Discharge					

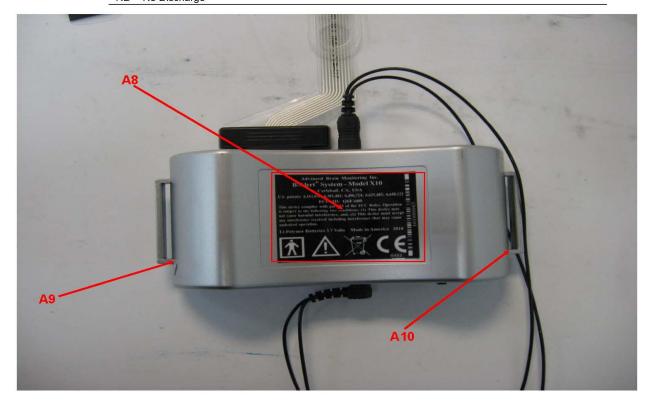


Tested by:	Lan Sayasane Printed	Signature
Reviewed by:	Stephen Rackleff Printed	Signature





Test Report#:	SC1010487	Test Area:	TR-1			
EUT Model #:	X10	Date:	December 21, 2010	•		
EUT Serial#:	101000003	EUT Power:	Battery 3.7 VDC	Temperature:	21.3	°C
Test Method:	EN61000-4-2			Air Pressure:	100.0	. kPa
Customer:	Advanced Brain Monitoring Systems			Relative Humidity:	58.7	%
EUT Description:	B-Alert System			Page: _4 of 4		
Notes:	Patient mode with calibration generate	or			-	,
	ND = No Discharge					



Tested by:	Lan Sayasane	and Sante
2.0 day-rest (2.0 day-2.0 day-	Printed	Signature
		Staplan Planton
Reviewed by:	Stephen Rackleff	
	Printed	Signature



RADIATED IMMUNITY



Test Report #:	SC1010487	Test Area:	SR-1	FACE DEFINITION (TOP VIEW)	В_	
EUT Model #:	X10	Date:	Dec. 1 & 20, 2010	T = Top U = Under Side	F (I	Front
EUT Serial#:	101000003	EUT Power:	Battery 3.7 VDC	Temperature:	21.5	°C
Test Method:	EN61000-4-3			Air Pressure:	100.6	kPa
Customer:	Advanced Brain Monitoring Systems			Relative Humidity:	24.3	%
EUT Description:	B-Alert System			Page: 1 of 1		
Notes:	Patient mode with calibration generate	or			7.0	

	T		Fi	l a	0	D	LEUT	0			F
TEST FREQUENCY	TEST LEVEL	MODULATION TYPE	FIELD POLAR.	ANTENNA DIST.	STEP	DWELL	FACE	COM	LIES	CRITERIA	REMARKS
(MHz)	(V/m)	(SEE KEY)	(HAV)	(METERS)	(%)	(SEC.)	I ACE	YES	No	MET	NEWARKS
80-1000	3	4	V	3	1	3	F	1		Α	
80-1000	3	4	н	3	1	3	F	1		Α	
80-1000	3	4	Н	3	1	3	L	√		Α	
80-1000	3	4	V	3	1	3	L	1		Α	
80-1000	3	4	V	3	1	3	R	1		Α	
80-1000	3	4	Н	3	1	3	R	V		Α	
80-1000	3	4	Н	3	1	3	В	1		Α	
80-1000	3	4	V	3	1	3	В	1		Α	
80-1000	3	4	V	3	1	3	Т	✓		Α	
80-1000	3	4	Н	3	1	3	Т	1		Α	
80-1000	3	4	Н	3	1	3	U	1		Α	
80-1000	3	4	V	3	1	3	U	1		Α	
1000-2500	3	4	V	3	1	3	F	>		Α	
1000-2500	з	4	Н	3	1	3	F	>		Α	
1000-2500	3	4	Н	3	1	3	L	>		Α	
1000-2500	з	4	V	3	1	3	L	>		A	
1000-2500	3	4	V	3	1	3	R	>		A	
1000-2500	3	4	Н	3	1	3	R	1		Α	
1000-2500	3	4	Н	3	1	3	В	✓		Α	
1000-2500	3	4	V	3	1	3	В	✓		Α	
1000-2500	3	4	V	3	1	3	T	1		Α	
1000-2500	3	4	Н	3	1	3	Т	1		Α	
1000-2500	3	4	Н	3	1	3	U	1		Α	
1000-2500	3	4	V	3	1	3	U	1		Α	
		I		1	l	ı	ı	ı			

Modulation Key # Туре Freq Shape Duty Depth Tested by: <u>Lan Sayasane</u> Printed AM PM 1 kHz Sine N/A 80% 2 3 4 5 Signature 50% 100% 200 Hz Square 2 Hz 10 Hz 80% 80% Sine Sine N/A AM Reviewed by: Stephen Rackleff Printed Signature

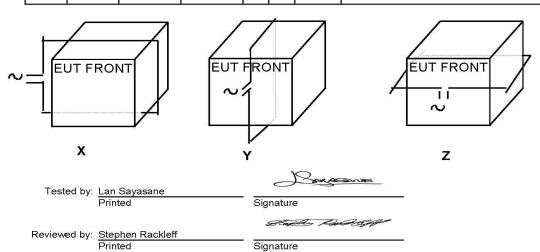


MAGNETIC FIELD IMMUNITY



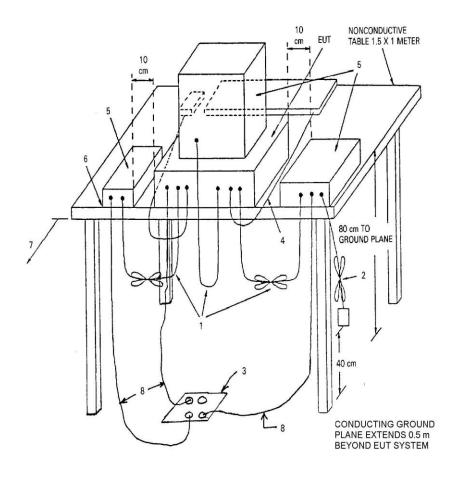
Test Report #:	SC1010487	Test Area:	TR-2	,		
EUT Model #:	X10	Date:	November 30, 2010			
EUT Serial#:	101000003	EUT Power:	Battery	Temperature:	23.1	°C
Test Method:	EN61000-4-8			Air Pressure:	101.3	kP
Customer:	Advanced Brain Monitoring Systems			Relative Humidity:	24.1	%
EUT Description:	B-Alert System			Page: <u>1 of 1</u>		
Notes:	Patient mode with calibration generate	or				

	FIELD	TIME FIELD	FREQUENCY	Сом	PLIES		
AXIS	STRENGTH	APPLIED	OF MAG FIELD			CRITERIA	REMARKS
(X,Y,Z)	(A/m)	(SECONDS)	(Hz)	YES	No	MET	
Х	3	60	50	1		Α	
Υ	3	60	50	1		Α	
Z	3	60	50	✓		Α	
Х	3	60	60	V		Α	
Υ	3	60	60	1		Α	
Z	3	60	60	1		Α	
			i				
			İ				



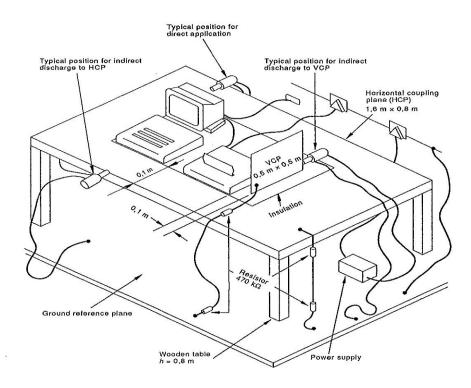


Radiated Emissions Test Setup, 30 to 1000 MHz





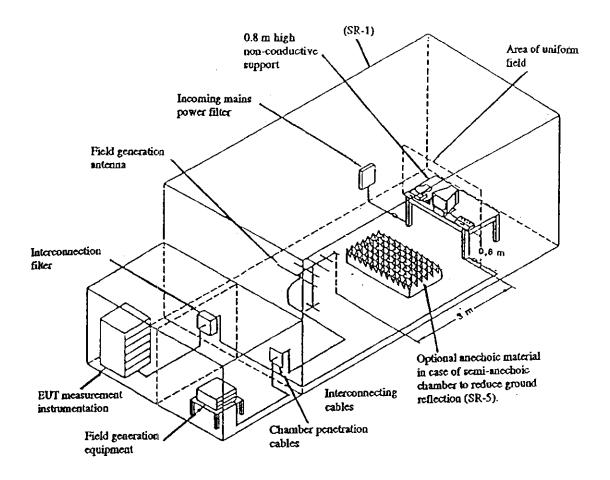
Test Configuration for ESD, Tabletop Unit



Dimensions in metres



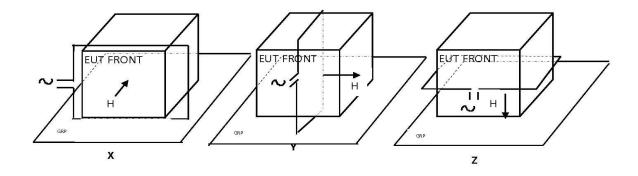
Test Configuration for Radiated E Fields Immunity

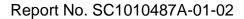


NOTE - Anechoic lining material on walls and ceiling has been omitted for clarity.



Test Setup for Power Frequency Magnetic Field





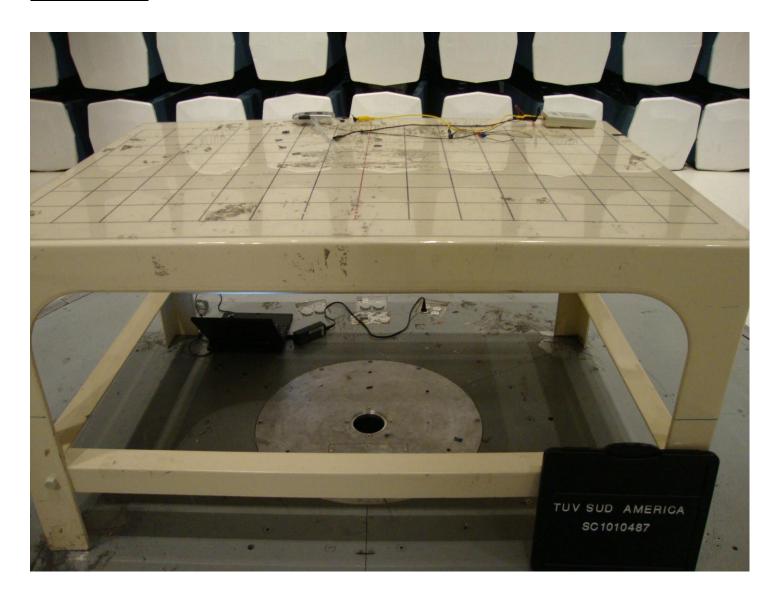


Appendix A

Test Setups (Photographs)

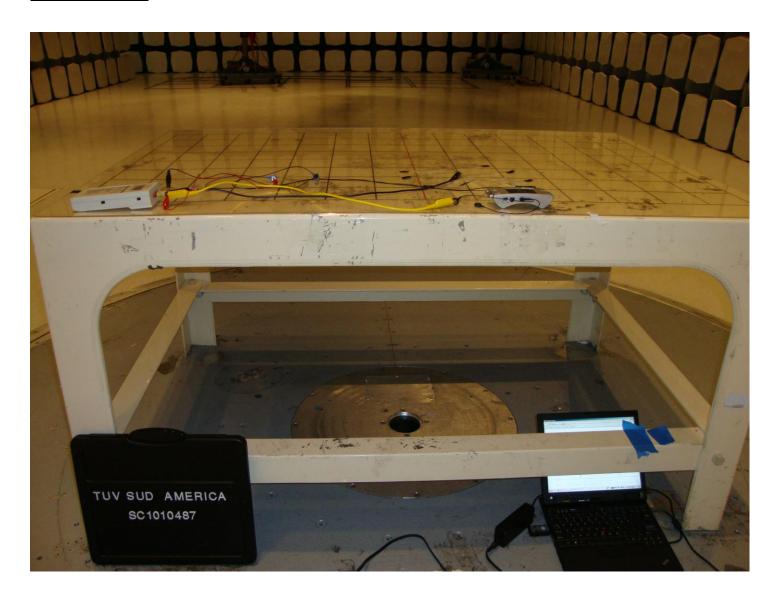


Photograph of Test Setup: Radiated Emissions:



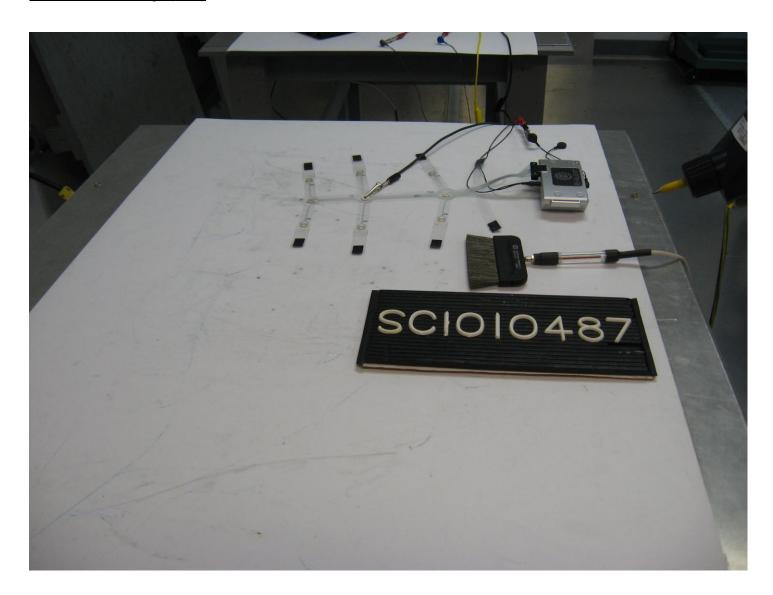


Photograph of Test Setup: Radiated Emissions:





Photograph of Test Setup: <u>Electrostatic Discharge (ESD)</u>:





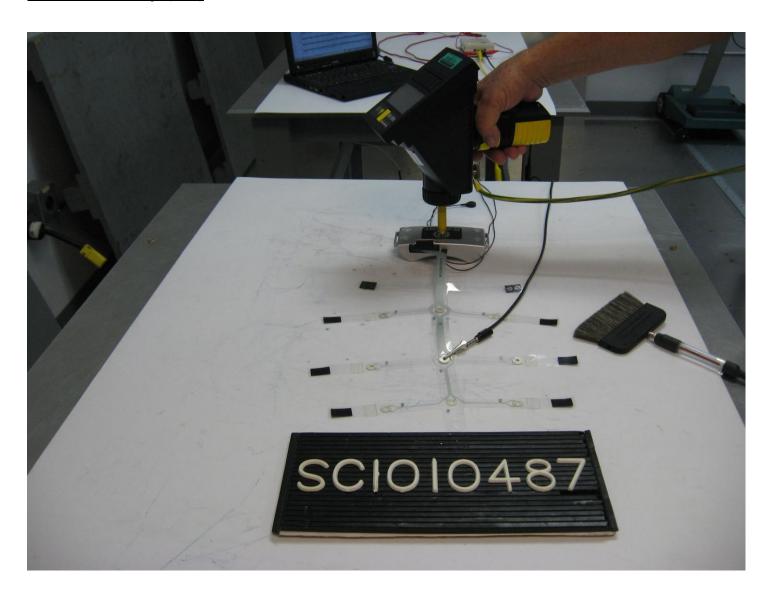
Photograph of Test Setup: <u>Electrostatic Discharge (ESD)</u>:



Rev.No 1.0



Photograph of Test Setup: <u>Electrostatic Discharge (ESD)</u>:



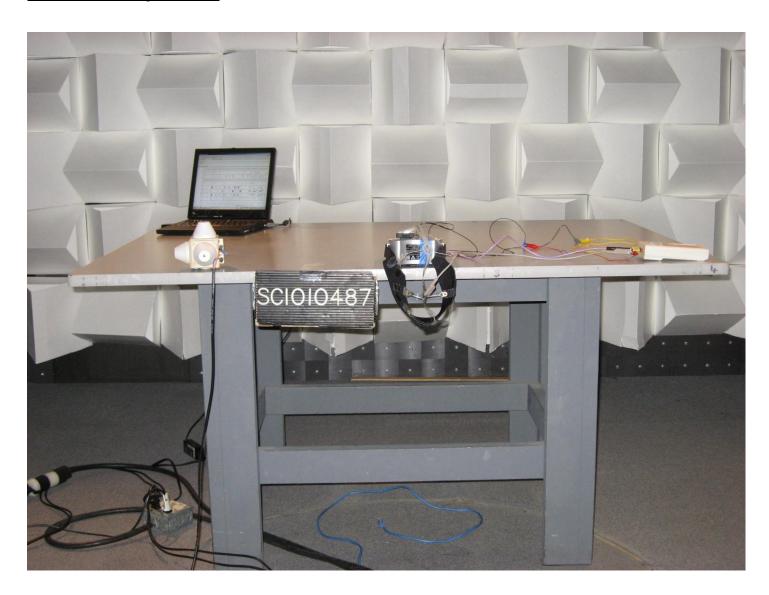


Photograph of Test Setup: Radiated Electromagnetic Fields:





Photograph of Test Setup: Radiated Electromagnetic Fields:





Photograph of Test Setup: Power Frequency Magnetic Field:





Appendix B

Product Information Form(s)



Form



EMC Test Plan and Constructional Data Form

PLEASE COMPLETE THIS DOCUMENT IN FULL, ENTERING N/A IF THE FIELD IS NOT APPLICABLE. IF TESTING RESULTS IN MODIFICATIONS TO THE EQUIPMENT, PLEASE SUBMIT A REVISED TP/CDF INDICATING THOSE MODIFICATIONS. NOTE: This information will be input into your test report as shown below. Press the F1 key at any time to get HELP for the current field selected. Advanced Brain Monitoring, Inc. Company: Address: 2237 Faraday Avenue, Suite 100 Carlsbad, CA 92008 Contact: Gene Davis Position: Technical Sales and Services Director Phone: 760-720-0099 x 6007 Fax: 760-476-3620 E-mail Address: Gene@b-alert.com General Equipment Description -- NOTE: This information will be input into your test report as shown below. **EUT Description** 10 Channel System with 9 channels of EEG and 1 channel of ECG **EUT Name** B-Alert X10 Model No .: X10 101000003 Serial No.: Product Options: Configurations to be tested: Equipment Modification (If applicable, indicate modifications since EUT was last tested. If modifications are made during this testing, submit revised TP/CDF after testing is complete.) Modifications since last test: Modifications made during test: Test Objective(s): Please indicate the tests to be performed, entering the applicable standard(s) where noted. EMC Directive 2004/108/EC (EMC) FCC: Class VCCI: Class А □ В Std: Machinery Directive 89/392/EEC (EMC) BSMI: Class □ A В (Separate Report) Canada: Class Α В Std: Medical Device Directive 93/42/EEC (EMC) Australia: Class Α Std: Other: Vehicle Directive: ☐ 2001/3/EC (EMC) ☐ 2004/104/EC (EMC) ☐ Other Vehicle Std: ☐ FDA Reviewers Guidance for Premarket Notification Submissions (EMC) Third Party Certification, if applicable (*Signature on Page 6 Required) Attestation of Conformity (AoC)* EMC Certification (used with Octagon Mark)* Statement of Compliance (previously CoC)3 Compliance Document* Protection Class (N/A for vehicles) Class I ☐ Class II ☐ Class III (Press **F1** when field is selected to show additional information on Protection Class.)

FILE: EMCU_F09.02E, REVISION 10, Effective: 20 Feb 2008

FCC / TCB Certification E-Mark Certification

Page 1 of 6

Industry Canada / FCB Certification

Taiwan Certification



Form



EMC Test Plan and Constructional Data Form Attendance Attended by the customer Unattended by the customer Test will be: Failure - Complete this section if testing will not be attended by the customer. If a failure occurs, TÜV SÜD America should □ Call contact listed above, if not available then stop testing. (After hrs phone): 760-716-8757 Continue testing to complete test series. Continue testing to define corrective action. Stop testing. **EUT Specifications and Requirements** Width: 2 and 1/8" Height: 1 and 1/8" Weight: 4 ounces Power Requirements Regulations require testing to be performed at typical power ratings in the countries of intended use. (i.e., European power is typically 230 VAC 50 Hz or 400 VAC 50 Hz, single and three phase, respectively) (If battery powered, make sure battery life is sufficient to complete testing.) Voltage: Powered by 2 3.7V Lithium Ion Batteries # of Phases: 1 Current Current (Amps/phase(max)): 50mA (Amps/phase(nominal)): 40mA Other Other Special Requirements

Typical Installation and/or Operating Environment

(ie. Hospital, Small Business, Industrial/Factory, etc.)
Prepared, charged and applied at Health Care Facility by Trained Technician. Worn by patient at Health Care Facility.

Ë	EUT Power Cable								
	Permanent	OR		Removable	Length (in meters):				
	Shielded	OR		Unshielded	00e00 0000 -				
\boxtimes	Not Applicable	e							

FILE: EMCU_F09.02E, REVISION 10, Effective: 20 Feb 2008

Page 2 of 6



Form



EMC Test Plan and Constructional Data Form

EUT Interface	e P	orts	an	ıd C	able	s								
<u></u>			Du	ring est			S	Shielding				sted 'S)	e e	Į,
Туре	Analog	Digital	Active	Passive	Q.	Yes	8	Туре	Termination	Connector Type	Port Termination	Length tested (in meters)	Removable	Permanent
EXAMPLE: RS232		×	×		2	×		Foil over braid	Coavial	Metallized 9- pin D-Sub	Characteristic Impedance	6	IZI	
B-Alert Dongle			☒					7 GW GVG, STAIR	Coaxiai	USB A		, i		Ō
USB A To Micro-B For Charging			☒			\boxtimes		Foil over braid		USB A and USB Micro-B		1		
-														

FILE: EMCU_F09.02E, REVISION 10, Effective: 20 Feb 2008

Page 3 of 6



Form



EMC Test Plan and Constructional Data Form

EUT Software

Revision Level: ROME 2.0.2, ATHENA 2.0.2

Description: Software is used for connecting to and acquiring data from the wireless EEG

Headset

Equipment Under Test (EUT) Operating Modes to be Tested -- list the operating modes to be used during test. It is recommended the equipment be tested while operating in a typical operation mode. FCC testing of personal computers and/or peripherals requires that a simple program generate a complete line of upper case H's. Provide a general description of all software, firmware, and PLD algorithms used in the equipment. List all code modules as described above, with the revision level used during testing. Consult with your TÜV Product Service Representative if additional assistance is required.

- 1. Acquisition
- 2. Battery Charging

3.

Description	Model #	Serial #	FCC ID #
3-Alert X10	X10	101000003	????
,	21.5	10100000	

FILE: EMCU_F09.02E, REVISION 10, Effective: 20 Feb 2008

Page 4 of 6



Form



EMC Test Plan and Constructional Data Form

Support Equ This information				oort equipmer	nt which is not pa	art of the EUT. (i.e. peripherals, simulators, etc)
Description		Mod	el#	100	Serial #	FCC ID #
Charging Kit f	EK-5200		1	NA		
0						
Oscillator Fro	equencies					Ĭ
2	equentities	Derived	į.			
Manufacturer	Frequency	Freque	псу	Componer	nt#/Location	Description of Use
Citizen	5.0688MHz	5.0688	BMHz	Q1		Main processor oscillator clock
Power Suppl	V					
Manufacturer	Model	#	Serial 7	#	Туре	
NA - battery					Switche	d-mode: (Frequency)
Powered					Linear	Other:
					☐ Switche	
					Linear	Other:
Power Line F	ilters					
Manufacturer		Model #			Location in El	UT
NA - battery powered						

FILE: EMCU_F09.02E, REVISION 10, Effective: 20 Feb 2008

Page 5 of 6



Form



EMC Test Plan and Constructional Data Form

Description	Manufacturer	Part # or Value	Qty	Component # / Location
Ferrite	Murata	BLM18BN252S N1D	2	L1,L2

EMC Critical Detail -- Describe other EMC Design details used to reduce high frequency noise.

All ferrite parts are used to reduce EMI.

PLEASE ENTER NAMES BELOW	(INSERT	ELECTRONIC	SIGNATURE	IF POSSIBLE)
--------------------------	---------	-------------------	-----------	--------------

TELENOL ENTERNAL DELOTE (INCLINE ELECTRICATION OF THE IN THOSOLDE)								
Authorization (Signature Required if a Third Party Certification is checked on pg 1)								
November 29, 2010								
Date								
November 29, 2010								
Date								
÷	November 29, 2010 Date November 29, 2010							

FILE: EMCU_F09.02E, REVISION 10, Effective: 20 Feb 2008

Page 6 of 6



-					-
Λі	pp	nn	MI.	v	•
\sim	UU	CII	u		u

Change History

Not Applicable



Appendix D

Supplemental Information

Not Applicable